

Notice of References Cited	Application/Control No. 10/738,421		Applicant(s)/Patent Under Reexamination NAKATANI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0060170	03-2003	Tikka et al.	455/73
*	B	US-2004/0056819	03-2004	McCarthy et al.	343/850
*	C	US-2001/0022544	09-2001	Endoh et al.	333/193
*	D	US-6,308,051	10-2001	Atokawa, Masayuki	455/78
*	E	US-6,085,071	07-2000	Yamada et al.	455/82
*	F	US-6,891,450	05-2005	Nakamura et al.	333/193
*	G	US-5,910,756	06-1999	Ella, Juha	333/133
*	H	US-6,721,544	04-2004	Franca-Neto, Luiz M.	455/83
*	I	US-2002/0171508	11-2002	Harada et al.	333/133
*	J	US-2003/0054791	03-2003	Sayers, Anthony D.	455/338
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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